



**Note to CIML Members and  
OIML Corresponding Members**

**Subject: First announcement - OIML Seminar on Conformity To Type (CTT)**

Dear Colleagues,

At its 45th Meeting in Orlando (USA) in 2010 the CIML passed the following two Resolutions:

*Resolution 15: The Committee supports the organization of a seminar on the subject of Conformity to Type (CTT) and strongly encourages its Members to actively contribute to this seminar.*

and

*Resolution 19: The Committee,  
Considering the proposals by its Member for Australia for a new project and a new (Sub)Committee on Conformity to Type (CTT), and  
Considering the comments received during the consultation of the members of the Presidential Council and the subsequent consultation of all CIML Members and relevant liaison organizations,  
Resolves that a decision on the proposals shall be postponed until after the conclusions of a seminar on CTT, mentioned in Resolution No. 15, have become available; and  
Instructs the Bureau to facilitate an electronic working group, chaired by the Member for New Zealand, with the objective to prepare the program for that seminar, taking into account the issues raised in the comments received.*

The BIML, with the kind assistance of the NMi, the Netherlands, is organizing the seminar on CTT on

**Wednesday, 29 and Thursday 30 June 2011 in Utrecht, the Netherlands.**

The purpose of the seminar is to identify and discuss the various issues surrounding CTT with a view to preparing for discussions and possible Resolutions during the 46th CIML Meeting in Prague in October.

A program for the seminar, drawn up by the working group convened by Mr. Stephen O'Brien, CIML Member for New Zealand, and information about the venue arrangements and hotels in Utrecht will shortly be posted on the OIML web site.

*Note on other events (<http://www.oiml.org/updates/calendar.html>)*

The seminar is being organized in conjunction with a meeting of OIML TC 5/SC 1 (27 and 28 June 2011, at the same location as the CTT seminar) to review the comments received on the first Committee Draft of the revision of OIML D 11:2004.

In the week preceding the TC 5/SC 1 meeting and the CTT seminar, a workshop on *Statistical methods in verification*, organized by the secretariat of TC 3/SC 4 (21 June 2011) and a meeting of TC 12 on the revision of OIML R 46 *Electricity meters* (22–24 June 2011) have also been scheduled to take place in London, UK.

Yours faithfully,

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